

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
FINK, STEVEN T.

Examiner

SATISH CHANDRA

Art Unit

1792

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,634,845	10-2003	Komino, Mitsuaki	414/217
*	B	US-5,391,260	02-1995	Makino et al.	216/69
*	C	US-2001/0016166	08-2001	Dandl et al.	417/48
*	D	US-6,178,918	01-2001	van Os et al.	118/723R
*	E	US-2003/0038111	02-2003	Carducci et al.	216/59
*	F	US-5,685,942	11-1997	Ishii, Nobuo	156/345.48
*	G	US-6,357,385	03-2002	Ohmi et al.	118/723AN
*	H	US-5,544,618	08-1996	Stall et al.	117/102
*	I	US-6,726,801	04-2004	Ahn, Jae-Su	156/345.29
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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